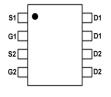


Main Product Characteristics:

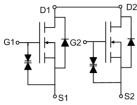
V_{DSS}	20V		
R _{DS} (on)	15.2mohm(typ.)		
I _D	7A ①		



DFN 3x3-8L



Marking and pin
Assignment



Schematic diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute Max Rating:

Symbol	Parameter	Max.	Units
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V(Silicon Limited)	7 ①	
I _D @ TC = 100°C	Continuous Drain Current, V _{GS} @ 10V	5 ①	Α
I _{DM}	Pulsed Drain Current ②	42	
P _D @TC = 25°C	Power Dissipation	1.4	W
V _{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-to-Source Voltage	± 12	V
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to + 150	°C





Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
		_	15.2	23	mΩ	V_{GS} =4.5 V , I_{D} = 4 A
R _{DS(on)}	Static Drain-to-Source on-resistance	_	15.9	24		V _{GS} =4V,I _D =4A
		_	17.6	30		V _{GS} =3.1V,I _D =4A
		ı	20.8	35		V _{GS} =2.5V,I _D =2A
V	Gate threshold voltage	0.5	_	1	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
$V_{GS(th)}$	Gate threshold voltage	ı	0.30	_	V	T _J = 125℃
I _{DSS}	Drain-to-Source leakage current	_	_	1	μA	$V_{DS} = 20V, V_{GS} = 0V$
Lana	Gate-to-Source forward leakage	ı	_	10	μΑ	V _{GS} =8V
I_{GSS}		_	_	-10		$V_{GS} = -8V$
Q_g	Total gate charge	_	24.1	_		$I_D = 7A$,
Q_{gs}	Gate-to-Source charge	_	1.4	_	nC	V _{DS} =10V,
Q_{gd}	Gate-to-Drain("Miller") charge		4.2	_		V _{GS} = 10V
t _{d(on)}	Turn-on delay time		5.3	_		
t _r	Rise time		18.2	_	nS	V_{GS} =4V, V_{DS} =10V,
t _{d(off)}	Turn-Off delay time		25	_	113	$R_L=2.86\Omega, I_D=3.5A$
t _f	Fall time		3			
C _{iss}	Input capacitance		681			$V_{GS} = 0V$,
C _{oss}	Output capacitance	_	124		pF $V_{DS} = 10V$,	
C _{rss}	Reverse transfer capacitance	_	117			f = 1MHz

Source-Drain Ratings and Characteristics

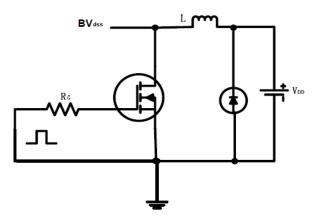
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current		_	7 ①	А	MOSFET symbol
	(Body Diode)	_				showing the
I _{SM}	Pulsed Source Current		_	42	А	integral reverse
	(Body Diode)					p-n junction diode.
V_{SD}	Diode Forward Voltage	_	0.7	1.2	V	I _S =1.5A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	34.3	_	nS	$T_J = 25^{\circ}C$, $I_F = 7A$, $di/dt =$
Q _{rr}	Reverse Recovery Charge	_	10.2	_	nC	100A/μs

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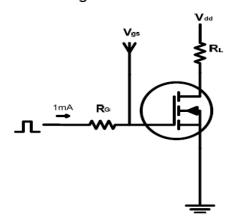


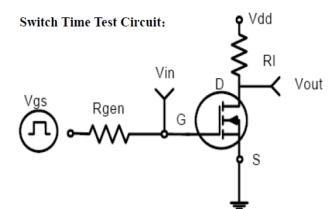
Test circuits and Waveforms

EAS test circuits:

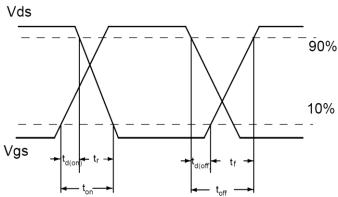


Gate charge test circuit:





Switch Waveforms:



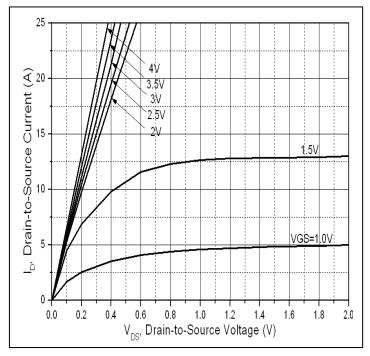
Version: 1.4

Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max junction temperature.
- 4 These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150$ °C.



Typical electrical and thermal characteristics



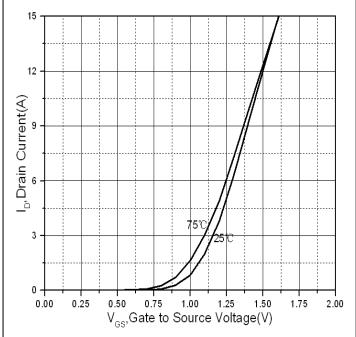


Figure 1: Typical Output Characteristics

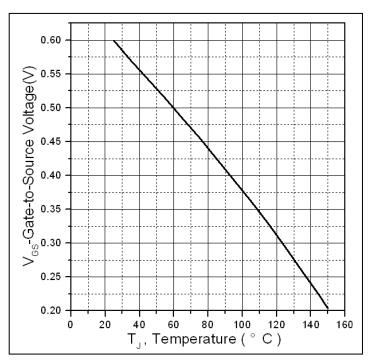


Figure 3. Gate to source cut-off voltage

Figure 2. Typical Transfer Characteristics

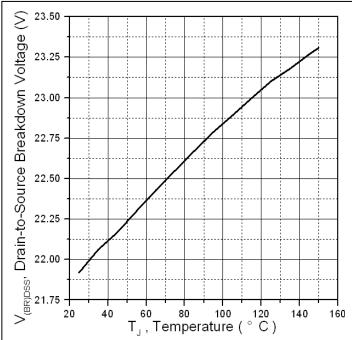
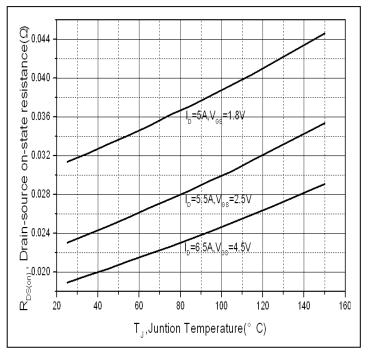


Figure 4: Drain-to-Source Breakdown Voltage vs.

Temperature



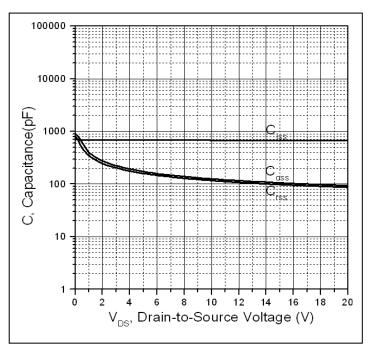
Typical electrical and thermal characteristics



10 V_{GS'} Gate-to-Source Voltage(V)

Figure 5. Normalized On-Resistance Vs. Case **Temperature**





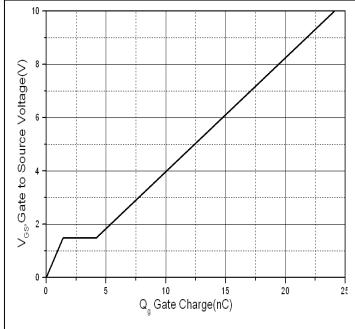
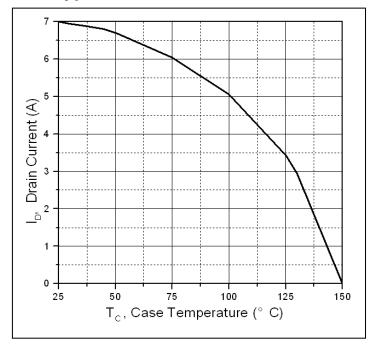


Figure 7. Typical Capacitance Vs. Drain-to-Source Voltage

Figure 8. Gate-Charge Characteristics



Typical electrical and thermal characteristics



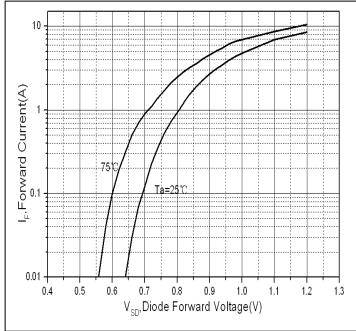
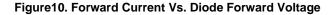


Figure 9. Maximum Drain Current Vs. Case Temperature



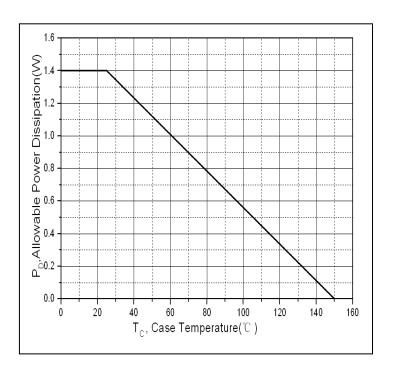
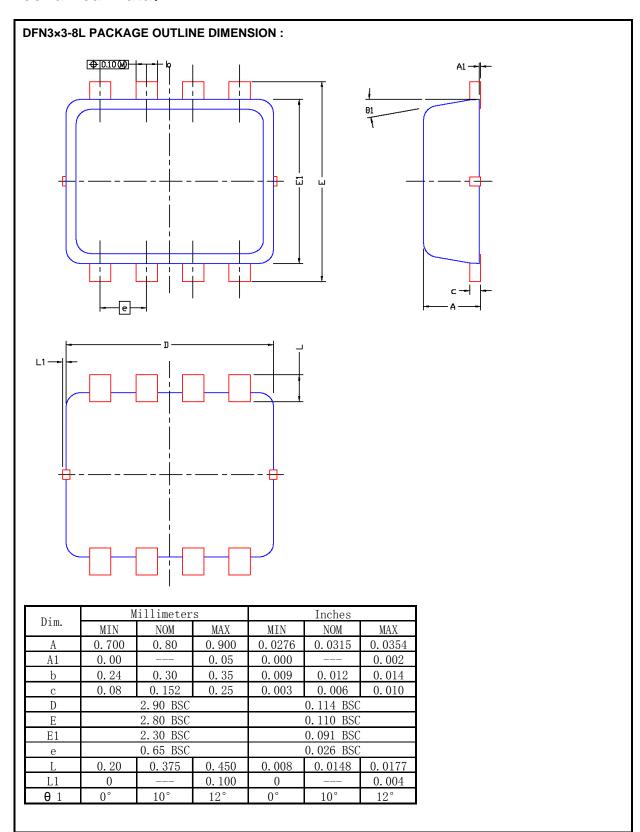


Figure 11. Power Dissipation Vs. Case Temperature



Mechanical Data:





Ordering and Marking Information

Device Marking: 2122E

Package (Available)

DFN 3x3-8L

Operating Temperature Range

C: -55 to 150 °C

Devices per Unit

Package	Units/	Tapes/	Units/	Inner Boxes/	Units/
Type	Tape	Inner Box	Inner Box	Carton Box	Carton Box
DFN 3x3-8L	3000pcs	4pcs	12000pcs	4pcs	48000pcs

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	Tj=125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /V _R	1000 hours	
Bias(HTRB)			
High	Tj=150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			

Version: 1.4



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